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Integrated Power MOSFET with PNP Low V_{CE(sat)} Switching Transistor

This integrated device represents a new level of safety and board–space reduction by combining the 20 V P–Channel FET with a PNP Silicon Low $V_{CE(sat)}$ switching transistor. This newly integrated product provides higher efficiency and accuracy for battery powered portable electronics.

Features

- Low R_{DS(on)} (MOSFET) and Low V_{CE(sat)} (Transistor)
- Higher Efficiency Extending Battery Life
- Logic Level Gate Drive (MOSFET)
- Performance DFN Package
- This is a Pb–Free Device

Applications

• Power Management in Portable and Battery–Powered Products; i.e., Cellular and Cordless Telephones and PCMCIA Cards

MAXIMUM RATINGS FOR P-CHANNEL FET

(T_A = 25° C unless otherwise noted)

Rating	Symbol	5 sec	Steady State	Unit
Drain-Source Voltage	V _{DS}	-2	V	
Gate-Source Voltage	V _{GS}	±	V	
Continuous Drain Current ($T_J = 150^{\circ}C$) (Note 1) $T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	I _D	-5.3 -3.8	-3.9 -2.8	A
Pulsed Drain Current	I _{DM}	±20		Α
Continuous Source Current (Note 1)	۱ _S	-5.3	-3.9	A
$\begin{array}{l} \mbox{Maximum Power Dissipation} \\ (\mbox{Note 1}) \\ T_A = 25^\circ\mbox{C} \\ T_A = 85^\circ\mbox{C} \end{array}$	P _D	2.5 1.3	1.3 0.7	W
Operating Junction and Storage Temperature Range	T _J , T _{stg}	–55 to +150		°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.27 in sq [1 oz] including traces).



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(Top View)





(Note: Microdot may be in either location)



ORDERING INFORMATION

Device	Package	Shipping [†]
NUS5530MNR2G	DFN8 (Pb–Free)	3000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MAXIMUM RATINGS FOR PNP TRANSISTORS (T_A = 25° C)

Rating	Symbol	Мах	Unit
Collector-Emitter Voltage	V _{CEO}	-35	Vdc
Collector-Base Voltage	V _{CBO}	-55	Vdc
Emitter-Base Voltage	V _{EBO}	-5.0	Vdc
Collector Current – Continuous	Ι _C	-2.0	Adc
Collector Current – Peak	I _{CM}	-7.0	A
Electrostatic Discharge	ESD	HBM Class 3 MM Class C	

THERMAL CHARACTERISTICS FOR P-CHANNEL FET

Characteristic	Symbol	Тур	Max	Unit
Maximum Junction-to-Ambient (Note 4) t ≤ 5 sec Steady State	$R_{ heta JA}$	40 80	50 95	°C/W
Maximum Junction-to-Foot (Drain) Steady State	$R_{ heta JF}$	15	20	°C/W

THERMAL CHARACTERISTICS FOR PNP TRANSISTORS

Characteristic	Symbol	Max	Unit
Total Device Dissipation	P _D (Note 1)	635	mW
Derate above 25°C		5.1	mW/°C
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$ (Note 1)	200	°C/W
Total Device Dissipation	P _D (Note 2)	1.35	W
Derate above 25°C		11	mW/°C
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$ (Note 2)	90	°C/W
Thermal Resistance, Junction-to-Lead #1	$R_{\theta JL}$	15	°C/W
Total Device Dissipation (Single Pulse < 10 sec)	P _{Dsingle} (Notes 2 & 3)	2.75	w
Junction and Storage Temperature Range	T _J , T _{stg}	–55 to +150	°C

FR-4 @ 100 mm², 1 oz copper traces.
 FR-4 @ 500 mm², 1 oz copper traces.
 Thermal response.

ELECTRICAL CHARACTERISTICS FOR P-CHANNE	L FET (T _J = 25°C unless otherwise noted)
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Characteristic	Symbol	Test Condition	Min	Тур	Max	Unit
Static						
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$	-0.6		-1.2	V
Gate-Body Leakage	I _{GSS}	V_{DS} = 0 V, V_{GS} = ±12 V			±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -16 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-1.0	μA
		$V_{DS} = -16 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, $ $T_J = 85^{\circ}\text{C}$			-5.0	
On-State Drain Current (Note 5)	I _{D(on)}	V_{DS} \leq –5.0 V, V_{GS} = –4.5 V	-20			А
Drain-Source On-State Resistance (Note 5)	r _{DS(on)}	$V_{GS} = -3.6 \text{ V}, \text{ I}_{D} = -1.0 \text{ A}$	-	0.050	0.06	Ω
		$V_{GS} = -2.5 \text{ V}, \text{ I}_{D} = -1.0 \text{ A}$		0.070	0.083	
Forward Transconductance (Note 5)	9 _{fs}	V _{DS} = -10 V, I _D = -3.9 A		12		Mhos
Diode Forward Voltage (Note 5)	V _{SD}	I _S = -2.1 A, V _{GS} = 0 V		-0.8	-1.2	V
Dynamic (Note 6)						
Total Gate Charge	Q _G			9.7	22	nC
Gate-Source Charge	Q _{GS}	V _{DS} = -10 V, V _{GS} = -4.5 V, I _D = -3.9 A		1.2		
Gate-Drain Charge	Q _{GD}			3.6		
Input Capacitance	C _{iss}			710		pF
Output Capacitance	C _{oss}	V _{DS} = -5.0 Vdc, V _{GS} = 0 Vdc, f = 1.0 MHz		400		
Reverse Transfer Capacitance	C _{rss}			140		
Turn-On Delay Time	t _{d(on)}			14	30	ns
Rise Time	t _r	$V_{DD} = -10 \text{ V}, \text{ R}_{\text{L}} = 10 \Omega$		22	55	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -1.0 \text{ A}, V_{\text{GEN}} = -4.5 \text{ V},$ $R_{\text{G}} = 6 \Omega$		42	100	
Fall Time	t _f			35	70	
Source-Drain Reverse Recovery Time	t _{rr}	l _F = −1.1 A, di/dt = 100 A/μs		30	60	

4. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.27 in sq [1 oz] including traces).
5. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
6. Guaranteed by design, not subject to production testing.

ELECTRICAL CHARACTERISTICS FOR PNP TRANSISTORS ($T_A = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Min	Typical	Max	Unit
OFF CHARACTERISTICS	•			•	
Collector – Emitter Breakdown Voltage ($I_C = -10 \text{ mAdc}, I_B = 0$)	V _{(BR)CEO}	-35	-45	-	Vdc
Collector – Base Breakdown Voltage ($I_{C} = -0.1 \text{ mAdc}, I_{E} = 0$)	V _{(BR)CBO}	-55	-65	-	Vdc
Emitter – Base Breakdown Voltage ($I_E = -0.1 \text{ mAdc}, I_C = 0$)	V _{(BR)EBO}	-5.0	-7.0	-	Vdc
Collector Cutoff Current (V _{CB} = -35 Vdc, I _E = 0)	I _{CBO}	-	-0.03	-0.1	μAdc
Collector-Emitter Cutoff Current (V _{CES} = -35 Vdc)	I _{CES}	-	-0.03	-0.1	μAdc
Emitter Cutoff Current (V _{EB} = -6.0 Vdc)	I _{EBO}	-	-0.01	-0.1	μAdc
ON CHARACTERISTICS					
DC Current Gain (Note 7) ($I_C = -1.0 \text{ A}, V_{CE} = -2.0 \text{ V}$) ($I_C = -1.5 \text{ A}, V_{CE} = -2.0 \text{ V}$) ($I_C = -2.0 \text{ A}, V_{CE} = -2.0 \text{ V}$)	h _{FE}	100 100 100	200 200 200	_ 400 _	
Collector – Emitter Saturation Voltage (Note 7) ($I_{C} = -0.1 \text{ A}, I_{B} = -0.010 \text{ A}$) ($I_{C} = -1.0 \text{ A}, I_{B} = -0.010 \text{ A}$) ($I_{C} = -2.0 \text{ A}, I_{B} = -0.02 \text{ A}$)	V _{CE(sat)}	- - -	- - -	-0.10 -0.15 -0.30	V
Base – Emitter Saturation Voltage (Note 7) ($I_C = -1.0 \text{ A}, I_B = -0.01 \text{ A}$)	V _{BE(sat)}	_	-0.68	-0.85	V
Base – Emitter Turn–on Voltage (Note 7) $(I_C = -2.0 \text{ A}, V_{CE} = -3.0 \text{ V})$	V _{BE(on)}	_	-0.81	-0.875	V
Cutoff Frequency (I _C = -100 mA, V _{CE} = -5.0 V, f = 100 MHz)	f _T	100	-	-	MHz
Input Capacitance (V _{EB} = -0.5 V, f = 1.0 MHz)	Cibo	-	600	650	pF
Output Capacitance (V_{CB} = -3.0 V, f = 1.0 MHz)	Cobo	-	85	100	pF
Turn-on Time (V _{CC} = -10 V, I _{B1} = -100 mA, I _C = -1 A, R _L = 3 Ω)	t _{on}	-	35	-	nS
Turn-off Time (V_{CC} = -10 V, I_{B1} = I_{B2} = -100 mA, I_{C} = 1 A, R_{L} = 3 \Omega)	t _{off}	-	225	-	nS

7. Pulsed Condition: Pulse Width = 300 $\mu sec,$ Duty Cycle \leq 2%

TYPICAL ELECTRICAL CHARACTERISTICS FOR P-CHANNEL FET





TYPICAL ELECTRICAL CHARACTERISTICS FOR P-CHANNEL FET



TYPICAL ELECTRICAL CHARACTERISTICS FOR PNP TRANSISTOR



TYPICAL ELECTRICAL CHARACTERISTICS FOR PNP TRANSISTOR





Figure 18. Normalized Thermal Response





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